## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination KRULL, WADE A. Examiner Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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1	υ	S. Wolf, Silicon Processing for the VLSI Era, Vol.3, Lattice Press (1995), pages 207-208 and 222-223				
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.